

Description

The AO4882-HXY uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

VDS = 40V ID = 8A

 $R_{DS(ON)} < 20m\Omega @ V_{GS}=10 V$

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

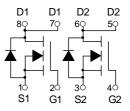
Pro	oduct ID	Pack	Marking	Qty(PCS)
AO	4882-HXY	SOP-8	4882 XXX YYYY	3000

Absolute Maximum Ratings@Tj=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	40	V
V _{GS}	Gate-Source Voltage	<u>+</u> 20	V
I _D @T _A =25℃	Drain Current, Vos @ 4.5V ³	8	А
I _D @T _A =70°C	Drain Current, V _{GS} @ 4.5V ³	6	A
Ідм	Pulsed Drain Current ¹	36	А
P _D @T _A =25℃	Total Power Dissipation	1.9	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction- ambient ³	40	°C/W



SOP-8



Dual N-Channel MOSFET



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V	
$\triangle BV_{DSS} / \triangle T$	BVDSS Temperature Coefficient	Reference to 25° C , I _D =1mA		0.032		V/°C	
Rds(on)	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =7A		16	20	mΩ	
		V _{GS} =4.5V , I _D =6A		20	26		
V _{GS(th)}	Gate Threshold Voltage	VGS=VDS . ID =250uA	1.2	1.6	2.5	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS=VDS , ID =2500A		-4.8		mV/°C	
1	Drein Course Lookage Current	V _{DS} =32V , V _{GS} =0V , T _J =25°C			1		
IDSS	Drain-Source Leakage Current	V _{DS} =32V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =7A		32		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.1		Ω	
Qg	Total Gate Charge (4.5V)			9.8			
Qgs	Gate-Source Charge	V _{DS} =32V , V _{GS} =4.5V , I _D =7A		2.8		nC	
Q_{gd}	Gate-Drain Charge			3.9			
T _{d(on)}	Turn-On Delay Time			2.8			
Tr	Rise Time	V_{DD} =20V , V_{GS} =10V , R_G =3.3 Ω		40.4		20	
T _{d(off)}	Turn-Off Delay Time	I _D =7A		22.8		ns	
T _f	Fall Time			6.4			
Ciss	Input Capacitance			1013			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		107		pF	
Crss	Reverse Transfer Capacitance			76			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,5}				8	А
I _{SM}	Pulsed Source Current ^{2,5}	-V _G =V _D =0V , Force Current			36	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time	IF=7A,dI/dt=100A/µs,		10		nS
Qrr	Reverse Recovery Charge	TJ=25°C		3.3		nC

Note :

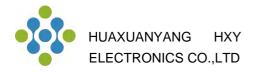
1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =25A

4.The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





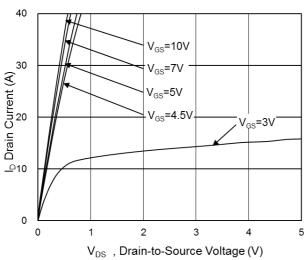


Fig.1 Typical Output Characteristics

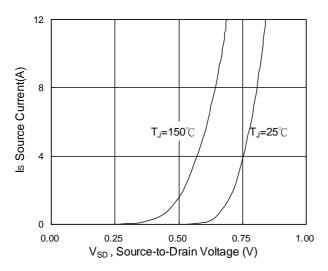


Fig.3 Forward Characteristics of Reverse

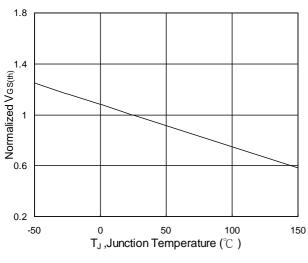


Fig.5 Normalized $V_{\text{GS}(\text{th})}$ vs. T_{J}

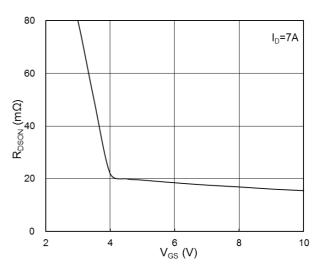


Fig.2 On-Resistance vs. G-S Voltage

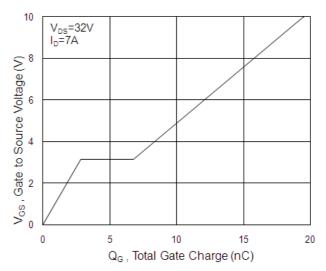


Fig.4 Gate-Charge Characteristics

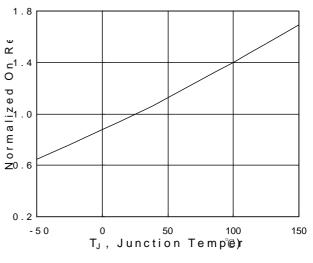


Fig.6 Normalized R_{DSON} vs. T_J



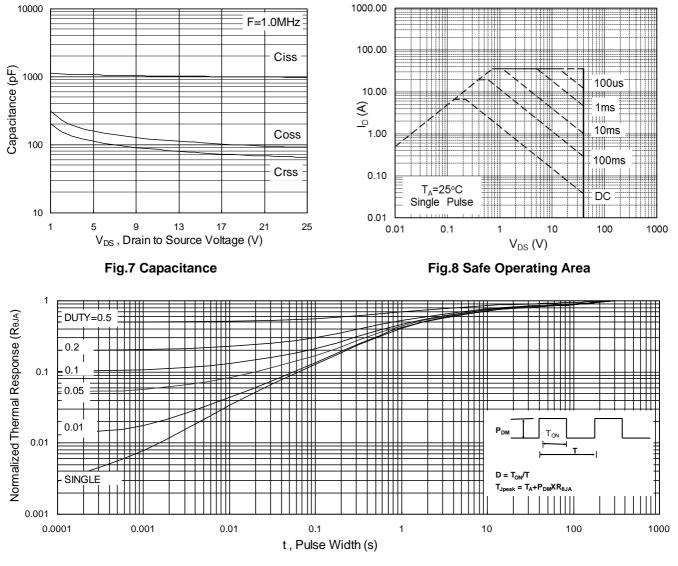


Fig.9 Normalized Maximum Transient Thermal Impedance

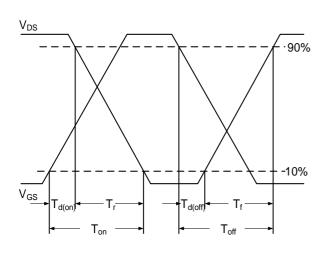


Fig.10 Switching Time Waveform

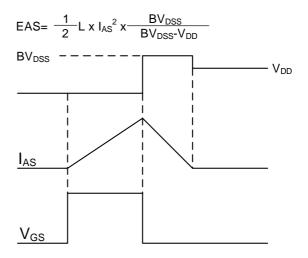
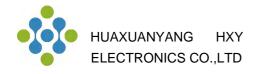
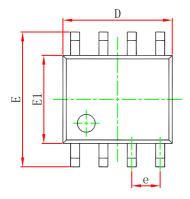
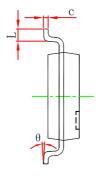


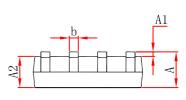
Fig.11 Unclamped Inductive Switching Waveform



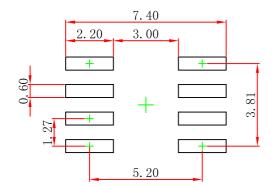
SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (1.270 (BSC)		(BSC)	
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	



- Note: 1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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